# TIBPAL16L8-25C, TIBPAL16R4-25C, TIBPAL16R6-25C, TIBPAL16R8-25C TIBPAL16L8-30M, TIBPAL16R4-30M, TIBPAL16R6-30M, TIBPAL16R8-30M LOW-POWER HIGH-PERFORMANCE IMPACT™ PAL® CIRCUITS

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**High-Performance Operation: Propagation Delay** C Suffix . . . 25 ns Max

M Suffix . . . 30 ns Max

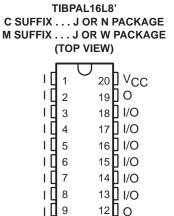
- Functionally Equivalent, but Faster Than PAL16L8A, PAL16R4A, PAL16R6A, and PAL16R8A
- Power-Up Clear on Registered Devices (All Register Outputs Are Set High, but Voltage Levels at the Output Pins Go Low)
- Package Options Include Both Plastic and **Ceramic Chip Carriers in Addition to Plastic** and Ceramic DIPs
- **Dependable Texas Instruments Quality and** Reliability

DEVICE	I INPUTS	3-STATE O OUTPUTS	REGISTERED Q OUTPUTS	I/O PORTS
PAL16L8	10	2	0	6
PAL16R4	8	0	4 (3-state buffers)	4
PAL16R6	8	0	6 (3-state buffers)	2
PAL16R8	8	0	8 (3-state buffers)	0

### description

These programmable array logic devices feature high speed and functional equivalency when compared with currently available devices. These IMPACT™ circuits combine the latest Advanced Low-Power Schottky technology with proven titanium-tungsten fuses to provide reliable, high-performance substitutes for conventional TTL logic. Their easy programmability allows for quick design of custom functions and typically results in a more compact circuit board. In addition, chip carriers are available for further reduction in board space.

The TIBPAL16' C series is characterized from 0°C to 75°C. The TIBPAL16' M series is characterized for operation over the full military temperature range of -55°C to 125°C.

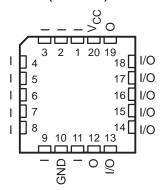


TIBPAL16L8' C SUFFIX . . . FN PACKAGE M SUFFIX . . . FK PACKAGE (TOP VIEW)

10

GND L

11 [] I





Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

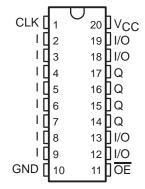
These devices are covered by U.S. Patent 4,410,987. IMPACT is a trademark of Texas Instruments. PAL is a registered trademark of Advanced Micro Devices Inc



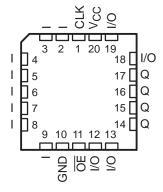
# TIBPAL16R4-25C, TIBPAL16R6-25C, TIBPAL16R8-25C TIBPAL16R4-30M, TIBPAL16R6-30M, TIBPAL16R8-30M LOW-POWER HIGH-PERFORMANCE *IMPACT™ PAL®* CIRCUITS

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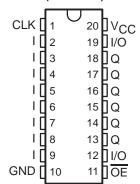




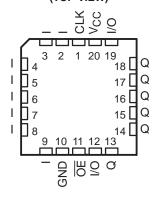
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M SUFFIX . . . FK PACKAGE
(TOP VIEW)



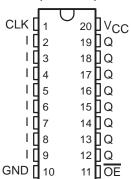
TIBPAL16R6'
C SUFFIX . . . J OR N PACKAGE
M SUFFIX . . . J OR W PACKAGE
(TOP VIEW)



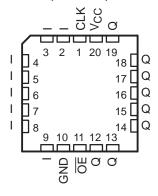
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M SUFFIX . . . FK PACKAGE
(TOP VIEW)



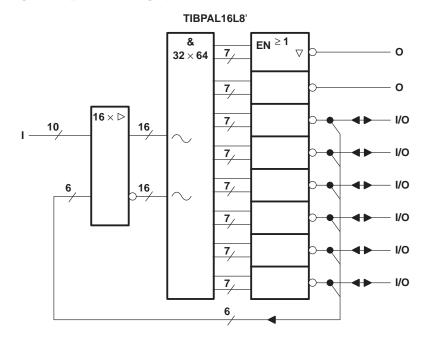
TIBPAL16R8'
C SUFFIX . . . J OR N PACKAGE
M SUFFIX . . . J OR W PACKAGE
(TOP VIEW)

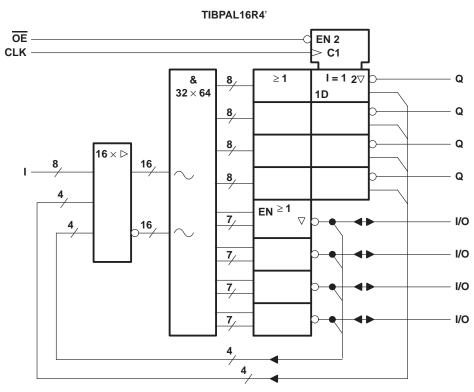


TIBPAL16R8'
C SUFFIX . . . FN PACKAGE
M SUFFIX . . . FK PACKAGE
(TOP VIEW)



# functional block diagrams (positive logic)



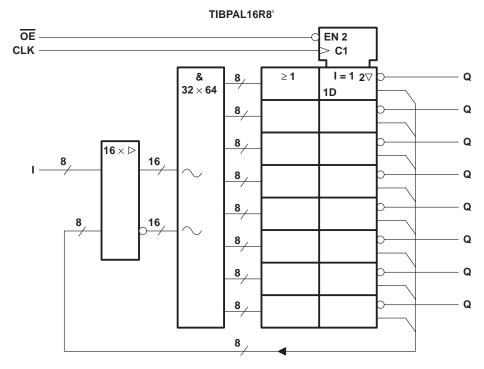


denotes fused inputs



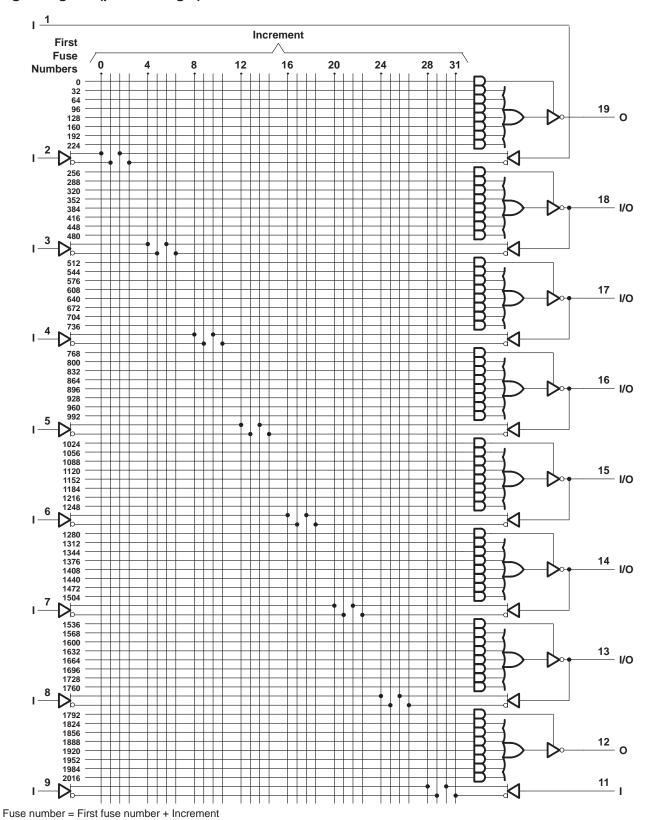
# functional block diagrams (positive logic)

### TIBPAL16R6' OE EN 2 CLK > C1 I = 1 2▽ - Q 8 32 × 64 1D 8 Q Q 8/ 16 × ⊳ 16 8 Q 6 8 Q 16 2 Q 8 $EN \ge 1$ 7 $\nabla$ I/O I/O 7

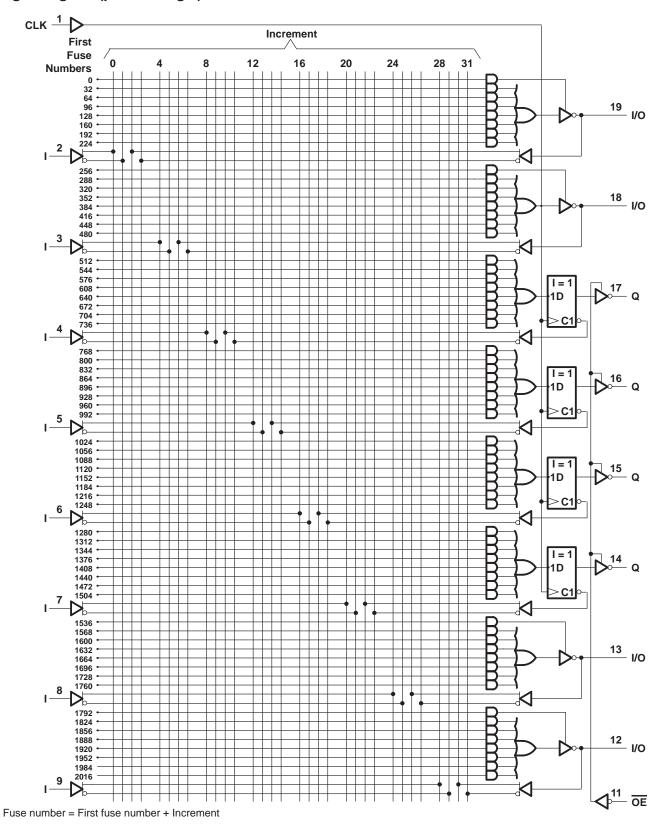


occupied denotes fused inputs

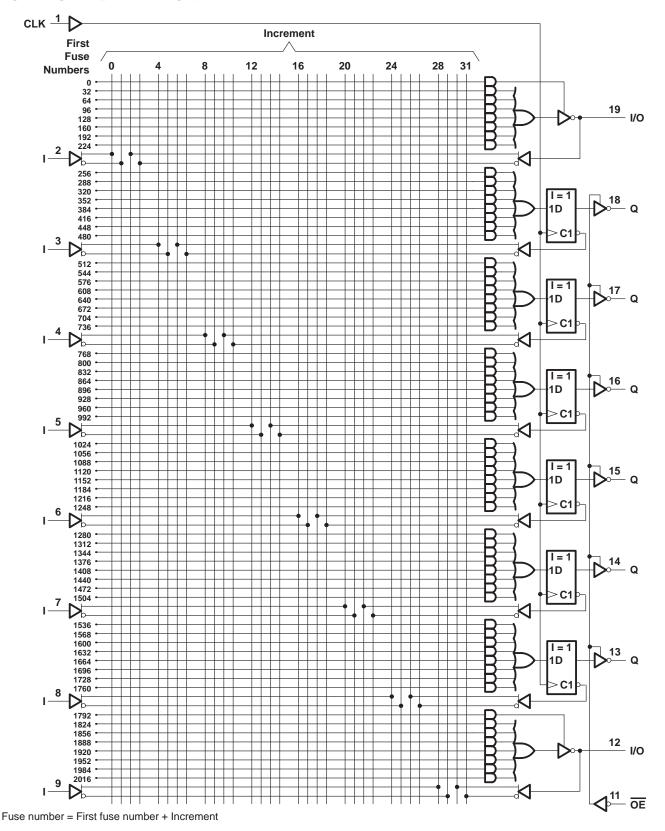






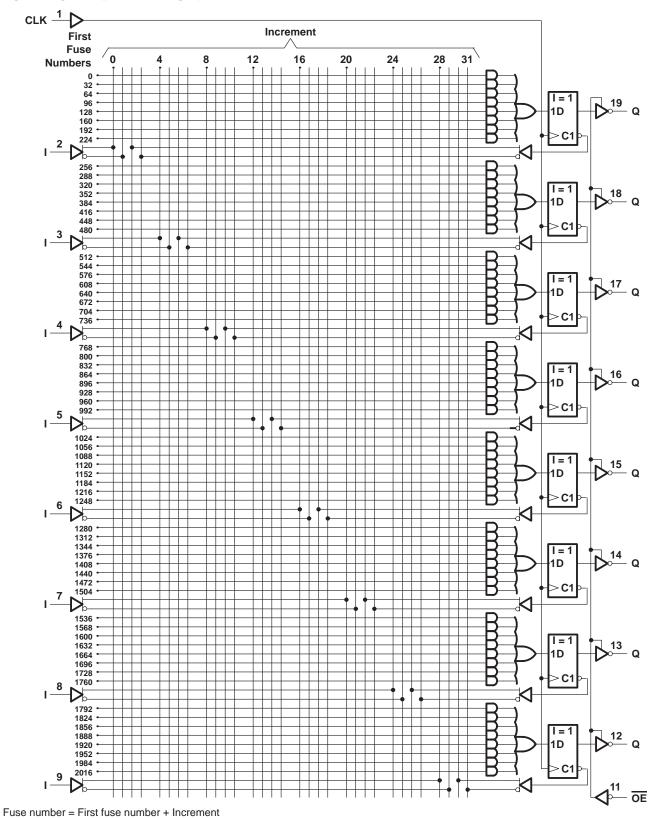








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# TIBPAL16L8-25C, TIBPAL16R4-25C, TIBPAL16R6-25C, TIBPAL16R8-25C LOW-POWER HIGH-PERFORMANCE *IMPACT™ PAL®* CIRCUITS

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# absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V <sub>CC</sub> (see Note 1)	7 V
Input voltage (see Note 1)	5.5 V
Voltage applied to disabled output (see Note 1)	5.5 V
Operating free-air temperature range	0°C to 75°C
Storage temperature range, T <sub>stq</sub> 65	5°C to 150°C

NOTE 1: These ratings apply, except for programming pins, during a programming cycle.

### recommended operating conditions

			MIN	NOM	MAX	UNIT
Vcc	Supply voltage		4.75	5	5.25	V
VIH	High-level input voltage		2		5.5	V
VIL	Low-level input voltage				0.8	V
IOH	IOH High-level output current				-3.2	mA
loL	I <sub>OL</sub> Low-level output current				24	mA
fclock	Clock frequency		0		30	MHz
	Pulse duration, clock (see Note 2)	High	10			ns
t <sub>W</sub>	Low		15			115
t <sub>su</sub>	Setup time, input or feedback before clock↑		20			ns
th	Hold time, input or feedback after clock↑		0			ns
TA	Operating free-air temperature		0	25	75	°C

NOTE 2: The total clock period of clock high and clock low must not exceed clock frequency, f<sub>clock</sub>. The minimum pulse durations specified are for clock high or low only, but not for both simultaneously.



# TIBPAL16L8-25C, TIBPAL16R4-25C, TIBPAL16R6-25C, TIBPAL16R8-25C LOW-POWER HIGH-PERFORMANCE $IMPACT^{TM}$ $PAL^{\textcircled{\tiny B}}$ CIRCUITS

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# electrical characteristics over recommended operating free-air temperature range

Р	ARAMETER		TEST CONDITIONS		MIN	TYP <sup>†</sup>	MAX	UNIT
VIK		$V_{CC} = 4.75 \text{ V},$	I <sub>I</sub> = -18 mA				-1.5	V
VOH		$V_{CC} = 4.75 \text{ V},$	$I_{OH} = -3.2 \text{ mA}$		2.4	3.3		V
VOL		$V_{CC} = 4.75 \text{ V},$	$I_{OL} = 24 \text{ mA}$			0.35	0.5	V
lo=u	Outputs	VCC = 5.25 V,	VO = 2.7 V				20	
lozh	I/O ports	VCC = 5.25 V,	V() = 2.7 V				100	μΑ
lo=	Outputs	V = 0 = 5 25 V	V 04V				-20	
IOZL	I/O ports	V <sub>CC</sub> = 5.25 V,	V <sub>O</sub> = 0.4 V				-250	μΑ
lį		V <sub>CC</sub> = 5.25 V,	V <sub>I</sub> = 5.5 V				0.1	mA
lн		V <sub>CC</sub> = 5.25 V,	V <sub>I</sub> = 2.7 V				20	μΑ
I∣L		V <sub>CC</sub> = 5.25 V,	V <sub>I</sub> = 0.4 V				-0.25	mA
I <sub>O</sub> ‡	·	$V_{CC} = 5.25 \text{ V},$	V <sub>O</sub> = 2.25 V		-30		-125	mA
Icc		V <sub>CC</sub> = 5.25 V,	V <sub>I</sub> = 0,	Outputs open		75	100	mA

# switching characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	түр†	MAX	UNIT
f <sub>max</sub>				30			MHz
t <sub>pd</sub>	I, I/O	O, I/O			15	25	ns
t <sub>pd</sub>	CLK↑	Q	R1 = $500 \Omega$ ,		10	15	ns
t <sub>en</sub>	OE↓	Q	R2 = 500 Ω,		15	20	ns
<sup>t</sup> dis	OE↑	Q	See Figure 3		10	20	ns
t <sub>en</sub>	I, I/O	O, I/O	]		14	25	ns
<sup>t</sup> dis	I, I/O	O, I/O			13	25	ns

<sup>&</sup>lt;sup>†</sup> All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .



<sup>†</sup> All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C. ‡ The output conditions have been chosen to produce a current that closely approximates one-half of the short-circuit output current, I<sub>OS</sub>.

# TIBPAL16L8-30M, TIBPAL16R4-30M, TIBPAL16R6-30M, TIBPAL16R8-30M LOW-POWER HIGH-PERFORMANCE *IMPACT* TM *PAL*® CIRCUITS

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# absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V <sub>CC</sub> (see Note 1)	7 V
Input voltage (see Note 1)	5.5 V
Voltage applied to disabled output (see Note 1)	5.5 V
Operating free-air temperature range	−55°C to 125°C
Storage temperature range, T <sub>stq</sub>	-65°C to 150°C

NOTE 1: These ratings apply, except for programming pins, during a programming cycle.

### recommended operating conditions

			MIN	NOM	MAX	UNIT
Vcc	Supply voltage		4.5	5	5.5	V
VIH	High-level input voltage		2		5.5	V
VIL	Low-level input voltage				0.8	V
IOH	IOH High-level output current				-2	mA
loL	IOL Low-level output current				12	mA
fclock	ck Clock frequency				25	MHz
	Dulas direction plants (and Nata O)	High	15			T
t <sub>W</sub>	Pulse duration, clock (see Note 2)		20			ns
t <sub>su</sub>	Setup time, input or feedback before clock					ns
th	Hold time, input or feedback after clock↑		0			ns
TA	Operating free-air temperature		-55	25	125	°C

NOTE 2: The total clock period of clock high and clock low must not exceed clock frequency, f<sub>clock</sub>. The minimum pulse durations specified are for clock high or low only, but not for both simultaneously.



# TIBPAL16L8-30M, TIBPAL16R4-30M, TIBPAL16R6-30M, TIBPAL16R8-30M LOW-POWER HIGH-PERFORMANCE $\mathit{IMPACT}^{\mathsf{TM}}$ $\mathit{PAL}^{\mathsf{B}}$ CIRCUITS

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# electrical characteristics over recommended operating free-air temperature range

P	ARAMETER		TEST CONDITION	S	MIN	TYP <sup>†</sup>	MAX	UNIT		
VIK		V <sub>CC</sub> = 4.5 V,	I <sub>I</sub> = -18 mA				-1.5	V		
Vон		V <sub>CC</sub> = 4.5 V,	$I_{OH} = -2 \text{ mA}$		2.4	3.2		V		
VOL		V <sub>CC</sub> = 4.5 V,	I <sub>OL</sub> = 12 mA			0.25	0.4	V		
1	Outputs	Vaa EEV	V- 27V				20	^		
IOZH	I/O ports	V <sub>CC</sub> = 5.5 V	$V_0 = 2.7 \text{ V}$				100	μΑ		
10.71	Outputs	V00 - 5 5 V	551/				-20			
lozL	I/O ports	V <sub>CC</sub> = 5.5 V,	VO = 0.4 V	$V_0 = 0.4 \text{ V}$			-250	μΑ		
١.	Pin 1, 11	V	V. 55V		V				0.2	mA
li l	All others	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 5.5 V				0.1	IIIA		
	Pin 1, 11						50			
ΙΗ	I/O ports	$V_{CC} = 5.5 V$ ,	$V_{I} = 2.7 \ V$				100	μΑ		
	All others	]								
1	I/O ports	Vaa 55V	V <sub>2</sub> 0.4.V				-0.25	A		
IIL	All others	V <sub>CC</sub> = 5.5 V,	VI = 0.4 V	V <sub>I</sub> = 0.4 V			-0.2	mA		
los <sup>‡</sup>		$V_{CC} = 5.5 \text{ V},$	V <sub>O</sub> = 0.5 V		-30		-250	mA		
Icc		$V_{CC} = 5.5 \text{ V},$	$V_{I} = 0,$	Outputs open		75	105	mA		

<sup>&</sup>lt;sup>†</sup> All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .

# switching characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
f <sub>max</sub>				25			MHz
<sup>t</sup> pd	I, I/O	O, I/O			15	30	ns
t <sub>pd</sub>	CLK↑	Q	R1 = 390 $\Omega$ ,		10	20	ns
t <sub>en</sub>	OE↓	Q	R2 = 750 Ω,		15	25	ns
<sup>t</sup> dis	OE↑	Q	See Figure 4		10	25	ns
t <sub>en</sub>	I, I/O	O, I/O			14	30	ns
<sup>t</sup> dis	I, I/O	O, I/O			13	30	ns

<sup>&</sup>lt;sup>†</sup> All typical values are at  $V_{CC}$  = 5 V,  $T_A$  = 25°C.

<sup>‡</sup> Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second. Set V<sub>O</sub> at 0.5 V to avoid test-equipment degradation.

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### programming information

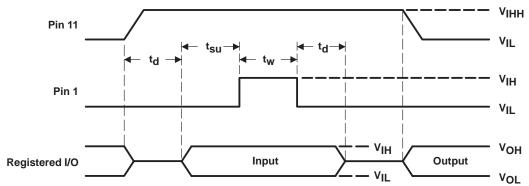
Texas Instruments programmable logic devices can be programmed using widely available software and inexpensive device programmers.

Complete programming specifications, algorithms, and the latest information on hardware, software, and firmware are available upon request. Information on programmers capable of programming Texas Instruments programmable logic also is available, upon request, from the nearest TI field sales office or local authorized TI distributor, by calling Texas Instruments at +1 (972) 644–5580, or by visiting the TI Semiconductor Home Page at www.ti.com/sc.

### preload procedure for registered outputs (see Figure 1 and Note 3)

The output registers can be preloaded to any desired state during device testing. This permits any state to be tested without having to step through the entire state-machine sequence. Each register is preloaded individually by following the steps given below.

- Step 1. With V<sub>CC</sub> at 5 V and Pin 1 at V<sub>IL</sub>, raise Pin 11 to V<sub>IHH</sub>.
- Step 2. Apply either  $V_{IL}$  or  $V_{IH}$  to the output corresponding to the register to be preloaded.
- Step 3. Pulse Pin 1, clocking in preload data.
- Step 4. Remove output voltage, then lower Pin 11 to  $V_{IL}$ . Preload can be verified by observing the voltage level at the output pin.



NOTE 3:  $t_d = t_{SU} = t_h = 100 \text{ ns to } 1000 \text{ ns V}_{IHH} = 10.25 \text{ V to } 10.75 \text{ V}$ 

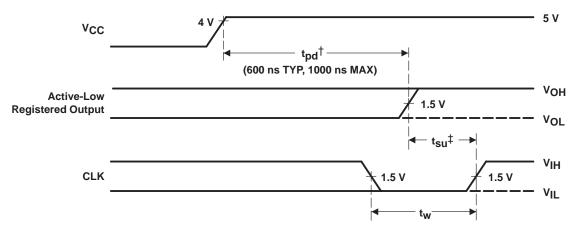
Figure 1. Preload Waveforms

# TIBPAL16L8-25C, TIBPAL16R4-25C, TIBPAL16R6-25C, TIBPAL16R8-25C TIBPAL16L8-30M, TIBPAL16R4-30M, TIBPAL16R6-30M, TIBPAL16R8-30M LOW-POWER HIGH-PERFORMANCE *IMPACT™ PAL®* CIRCUITS

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### power-up reset (see Figure 2)

Following power up, all registers are set high. This feature provides extra flexibility to the system designer and is especially valuable in simplifying state-machine initialization. To ensure a valid power-up reset, it is important that the rise of V<sub>CC</sub> be monotonic. Following power-up reset, a low-to-high clock transition must not occur until all applicable input and feedback setup times are met.



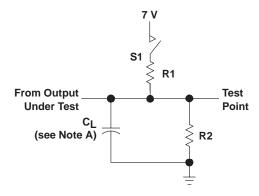
<sup>†</sup> This is the power-up reset time and applies to registered outputs only. The values shown are from characterization data.

Figure 2. Power-Up Reset Waveforms

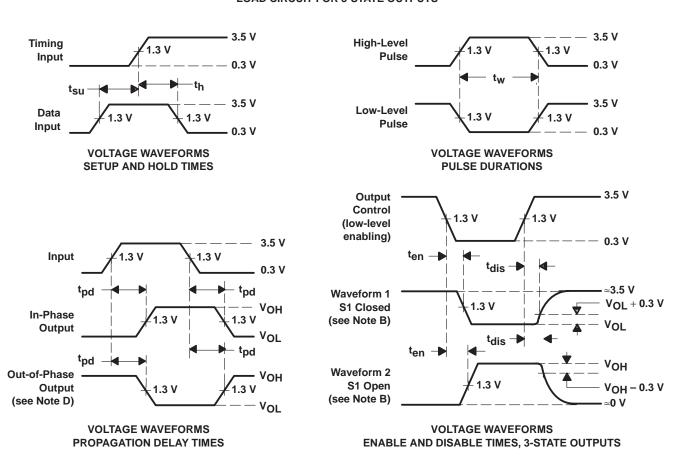


<sup>&</sup>lt;sup>‡</sup>This is the setup time for input or feedback.

### PARAMETER MEASUREMENT INFORMATION



### LOAD CIRCUIT FOR 3-STATE OUTPUTS

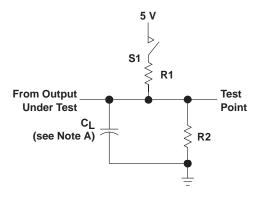


- NOTES: A.  $C_L$  includes probe and jig capacitance and is 50 pF for  $t_{pd}$  and  $t_{en}$ , 5 pF for  $t_{dis}$ .
  - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
  - C. All input pulses have the following characteristics: PRR  $\leq$  1 MHz,  $t_f = t_f \leq$  2 ns, duty cycle = 50%
  - D. When measuring propagation delay times of 3-state outputs from low to high, switch S1 is closed. When measuring propagation delay times of 3-state outputs from high to low, switch S1 is open.
  - E. Equivalent loads may be used for testing.

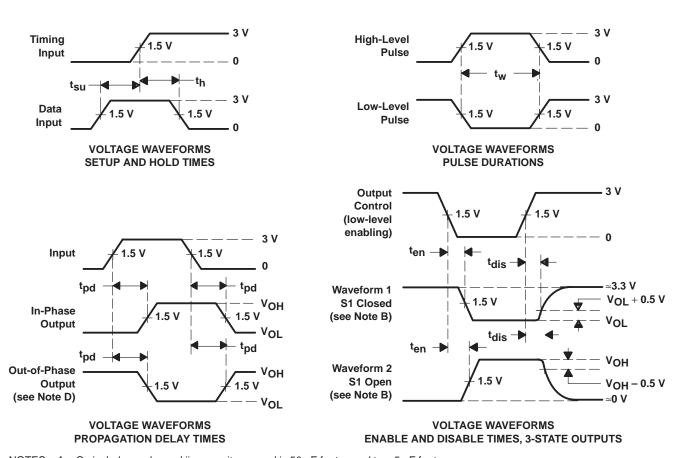
Figure 3. Load Circuit and Voltage Waveforms



### PARAMETER MEASUREMENT INFORMATION



### **LOAD CIRCUIT FOR 3-STATE OUTPUTS**



- NOTES: A.  $C_L$  includes probe and jig capacitance and is 50 pF for  $t_{pd}$  and  $t_{en}$ , 5 pF for  $t_{dis}$ .
  - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
  - C. All input pulses have the following characteristics: PRR  $\leq$  10 MHz,  $t_\Gamma$  =  $t_f \leq$  2 ns, duty cycle = 50%
  - D. When measuring propagation delay times of 3-state outputs, switch S1 is closed.
  - E. Equivalent loads may be used for testing.

Figure 4. Load Circuit and Voltage Waveforms









# **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
5962-85155052A	ACTIVE	LCCC	FK	20	1	TBD	Call TI	N / A for Pkg Type
5962-8515505RA	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
5962-8515505SA	ACTIVE	CFP	W	20	1	TBD	Call TI	N / A for Pkg Type
5962-85155062A	ACTIVE	LCCC	FK	20	1	TBD	Call TI	N / A for Pkg Type
5962-8515506RA	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
5962-8515506SA	ACTIVE	CFP	W	20	1	TBD	Call TI	N / A for Pkg Type
5962-85155072A	ACTIVE	LCCC	FK	20	1	TBD	Call TI	N / A for Pkg Type
5962-8515507RA	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
5962-8515507SA	ACTIVE	CFP	W	20	1	TBD	Call TI	N / A for Pkg Type
5962-85155082A	ACTIVE	LCCC	FK	20	1	TBD	Call TI	N / A for Pkg Type
5962-8515508RA	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
5962-8515508SA	ACTIVE	CFP	W	20	1	TBD	Call TI	N / A for Pkg Type
JM38510/50605BRA	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
JM38510/50606BRA	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
JM38510/50607BRA	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
JM38510/50608BRA	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
TIBPAL16L8-25CFN	ACTIVE	PLCC	FN	20	46	TBD	Call TI	Level-1-220-UNLIM
TIBPAL16L8-25CN	ACTIVE	PDIP	N	20	20	TBD	Call TI	N / A for Pkg Type
TIBPAL16L8-30MFKB	ACTIVE	LCCC	FK	20	1	TBD	Call TI	N / A for Pkg Type
TIBPAL16L8-30MJ	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
TIBPAL16L8-30MJB	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
TIBPAL16L8-30MWB	ACTIVE	CFP	W	20	1	TBD	Call TI	N / A for Pkg Type
TIBPAL16R4-25CFN	ACTIVE	PLCC	FN	20	46	TBD	Call TI	Level-1-220-UNLIM
TIBPAL16R4-25CN	ACTIVE	PDIP	N	20	20	TBD	Call TI	N / A for Pkg Type
TIBPAL16R4-30MFKB	ACTIVE	LCCC	FK	20	1	TBD	Call TI	N / A for Pkg Type
TIBPAL16R4-30MJ	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
TIBPAL16R4-30MJB	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
TIBPAL16R4-30MWB	ACTIVE	CFP	W	20	1	TBD	Call TI	N / A for Pkg Type
TIBPAL16R6-25CFN	ACTIVE	PLCC	FN	20	46	TBD	Call TI	Level-1-220-UNLIM
TIBPAL16R6-25CN	ACTIVE	PDIP	N	20	20	TBD	Call TI	N / A for Pkg Type
TIBPAL16R6-30MFKB	ACTIVE	LCCC	FK	20	1	TBD	Call TI	N / A for Pkg Type
TIBPAL16R6-30MJ	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
TIBPAL16R6-30MJB	ACTIVE	CDIP	J	20	1	TBD		N / A for Pkg Type
TIBPAL16R6-30MWB	ACTIVE	CFP	W	20	1	TBD	Call TI	N / A for Pkg Type
TIBPAL16R8-25CFN	ACTIVE	PLCC	FN	20	46	TBD	Call TI	Level-1-220-UNLIM
TIBPAL16R8-25CN	ACTIVE	PDIP	N	20	20	TBD	Call TI	N / A for Pkg Type
TIBPAL16R8-30MFKB	ACTIVE	LCCC	FK	20	1	TBD	Call TI	N / A for Pkg Type
TIBPAL16R8-30MJ	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
TIBPAL16R8-30MJB	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
TIBPAL16R8-30MWB	ACTIVE	CFP	W	20	1	TBD	Call TI	N / A for Pkg Type

<sup>(1)</sup> The marketing status values are defined as follows:



### PACKAGE OPTION ADDENDUM

12-Jan-2006

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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### 14 LEADS SHOWN

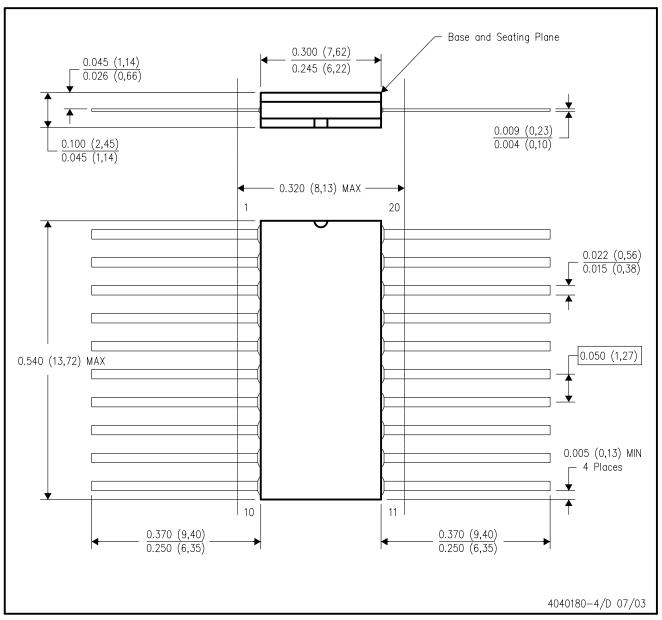


NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

# W (R-GDFP-F20)

# CERAMIC DUAL FLATPACK



NOTES:

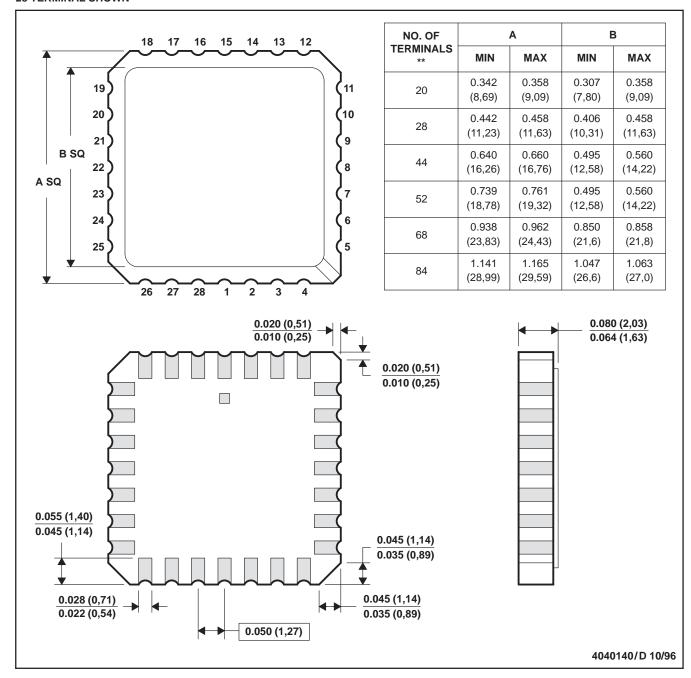
- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only.
- E. Falls within Mil-Std 1835 GDFP2-F20



### FK (S-CQCC-N\*\*)

### **28 TERMINAL SHOWN**

### **LEADLESS CERAMIC CHIP CARRIER**



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a metal lid.
- D. The terminals are gold plated.
- E. Falls within JEDEC MS-004



# N (R-PDIP-T\*\*)

# PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



NOTES:

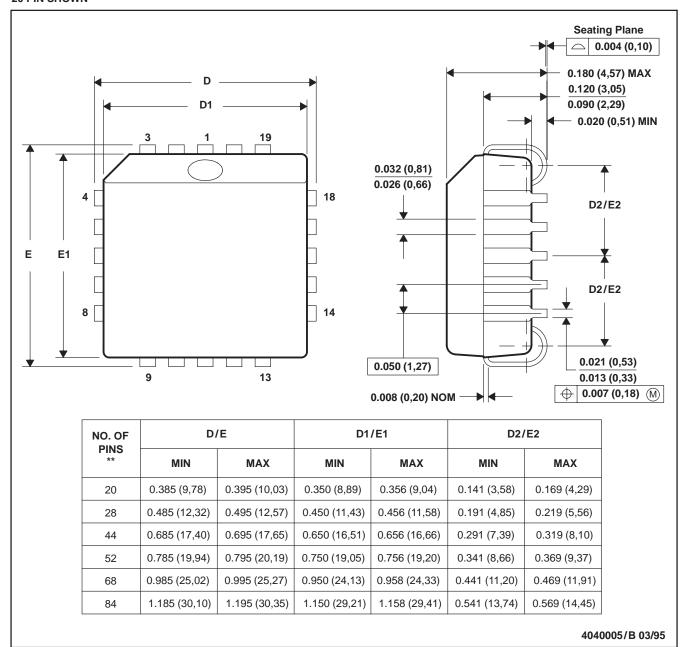
- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.



### FN (S-PQCC-J\*\*)

### 20 PIN SHOWN

### PLASTIC J-LEADED CHIP CARRIER



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Falls within JEDEC MS-018

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